Features

- Ultra-low Q_G For High Efficiency
- Logic Level
- Light Weight TBD grams
- New Compact Hermetic Package with Dual Gate
- Source Sense Pin
- Total Dose
 - Rated to 1000 krad
- Single Event
 - SEE immunity for LET of 85 MeV/mg/cm² with V_{DS} up to 100% of rated Breakdown
- Low Dose Rate at 100 mRad/sec
 - Maintains Pre-Rad specification
- Neutron
 - Maintains Pre-Rad specification for up to 3 x 10¹⁵ Neutrons/cm²

Applications

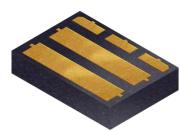
- Satellite and Avionics
- Deep Space Probes
- High Speed Rad Hard DC-DC Conversion
- Rad Hard Motor Controllers
- Nuclear Facilities

Thermal Characteristics

Symbol	Parameter-Conditions	Value	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 3)	TBD	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case	TBD	U/W







EPC7019G

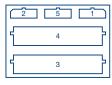
Rad Hard eGaN® 40 V, 95 A, PRELIMINARY 4.0 mΩ Surface Mount

Description

EPC Space FSMD-G series of eGaN® power switching HEMTs have been specifically designed for critical applications in the high reliability or commercial satellite space environments. These devices have exceptionally high electron mobility and a low temperature coefficient resulting in very low R_{DS(on)} values. The lateral structure of the die provides for very low gate charge (Q_G) and extremely fast switching times. These features enable faster power supply switching frequencies resulting in higher power densities, higher efficiencies and more compact packaging.

I/O Pin Assignment (Bottom View)

Pin	Symbol	Description
1	G	Gate
2	G	Gate
3	D	Drain
4	S	Source
5	SS	Source Sense





Absolute Maximum Rating ($T_C = 25^{\circ}$ C unless otherwise noted)

Symbol	Parameter-Conditions	Value	Units
Drain to Source Voltage (Note 1)		40	V
V_{DS}	Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	48	V
I _D	Continuous Drain Current ID @ V _{GS} = 5 V	95	
I _{DM}	Single-Pulse Drain Current t _{pulse} = 300 μs	530	А
V _{GS}	Gate to Source Voltage (Note 2)	+6 / -4	V
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C
T _{SOL}	Package Mounting Surface Temperature	260	
ESD	ESD Class	ΔΑ	



Static Characteristics ($T_C = 25^{\circ}$ C unless otherwise noted. Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units
Drain to Source Voltage	B _{VDSS}	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	40			V
Drain to Course Leakage		V - 40 V V - 0 V T - 125°C		0.001	0.4	
Drain to Source Leakage	IDSS	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{C} = 125^{\circ}\text{C}$		0.01		m 1
Gate to Source Forward Leakage		V 5 V T 40500		0.05	1.0	mA
Gate to Source Forward Leakage#	I _{GSS}	$V_{GS} = 5 \text{ V}, T_{C} = 125^{\circ}\text{C}$		0.2	4.0	
Gate to Source Reverse Leakage		$V_{GS} = -4 \text{ V}$		0.05	1.0	
Gate to Source Threshold Voltage	V _{GS(th)}		0.8	1.4	2.5	V
Gate to Source Threshold Voltage Temperature Coefficient	$\Delta V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 18 \text{ mA}$, $-55^{\circ}\text{C} < T_A < 150^{\circ}\text{C}$		-2.0		mV/°C
Drain to Source Resistance (Note 4)	R _{DS(on)}	$V_{GS} = 5 \text{ V}, I_D = 50 \text{ A}$		3.7	4.0	mΩ
Source to Drain Forward Voltage (Note 5)	V _{SD}	$I_S = 0.5 \text{ A}, V_G = 0 \text{ V}$		2.0		V

All measurements were done with substrate shorted to source.

Dynamic Characteristics ($T_C = 25^{\circ}C$ unless otherwise noted. Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units
Input Capacitance	C _{ISS}			2830		
Reverse transfer Capacitance	C _{RSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$		35		
Output Capacitance	C _{OSS}			1660		pF
Effective Output Capacitance, Energy Related	C _{OSS(ER)}	V 0+000VV 0V		2130		
Effective Output Capacitance, Time Related	C _{OSS(TR)}	$V_{DS} = 0$ to 20 V, $V_{GS} = 0$ V		2540		
Total Gate Charge	Q_{G}	$V_{DS} = 0$ to 20 V, $V_{GS} = 0$ V, $I_{D} = 50$ A		22		
Gate to Source Charge	Q_{GS}	V 00 V I 50 A		9.1		
Gate to Drain Charge	Q_{GD}	V _{DS} = 20 V, I _D = 50 A		3.4		nC
Output Charge (Note 6)	Q _{OSS}	$V_{DS} = 20 \text{ V}, \ V_{GS} = 0 \text{ V}$		51		
Source to Drain Recovery Charge	Q _{RR}			0		

All measurements were done with substrate shorted to source.

[#] Defined by design. Not subject to production test.



Radiation Characteristics

EPC Space eGaN® HEMTs are tested according to MIL-STD-750 Method 1019 for total ionizing dose validation. Every manufacturing lot is tested for total ionizing dose of Gamma radiation with an in-situ bias for (i) $V_{GS} = 5 \text{ V}$, (ii) $V_{DS} = V_{GS} = 0 \text{ V}$ and (iii) $V_{DS} = 80\% \text{ B}_{VDSS}$.

Electrical Characteristics up to 1000 krads ($T_C = 25^{\circ}$ C unless otherwise noted. Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units
Maximum Drain to Source Voltage	V _{DSMAX}	$V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ mA}$	40			V
Gate to Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 18 \text{ mA}$	0.8	1.4	2.5	V
Drain to Source Leakage	I _{DSS}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$		0.001	0.4	
Gate to Source Forward Leakage		V _{GS} = 5 V		0.05	1.0	mA
Gate to Source Reverse Leakage	IGSS	V _{GS} = -4 V		0.05	1.0	
Drain to Source Resistance (Note 4)	R _{DS(on)}	$I_D = 50 \text{ A}, V_{GS} = 5 \text{ V}$		3.7	4.0	mΩ

Typical Single Event Effect Safe Operating Area

Note: All Single Event Effect testing is performed on the K-500 Cyclotron at Texas A&M University

Test	Environment				V _{DS} Vol	tage (V)
	lon	LET MeV/mg/cm ²	Range µm	Energy MeV	V _{GS} = 0 V	V _{GS} = -4V
See SOA	Xe	50	131	1653	40	40
	Au	83.7	130	2482	40	40

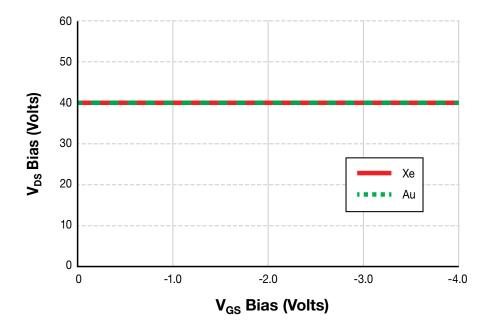


Figure 1: Typical Single Event Effect Safe Operating Area

Figure 2: Typical Output Characteristics at 25°C

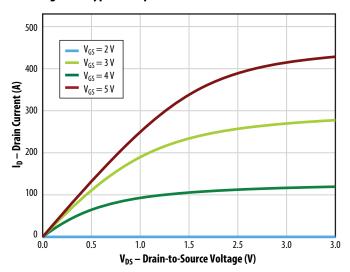


Figure 3: Typical Output Characteristics at 125°C

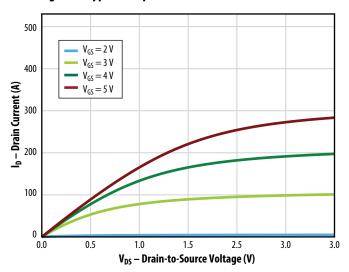


Figure 4: Typical Transfer Characteristics

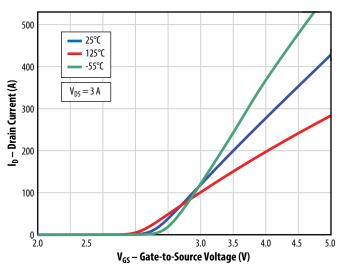


Figure 5: R_{DS(on)} vs. V_{GS} for Various Temperatures

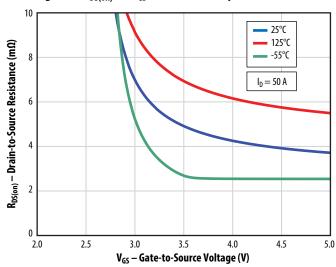


Figure 6: R_{DS(on)} vs. V_{GS} for Various Drain Currents

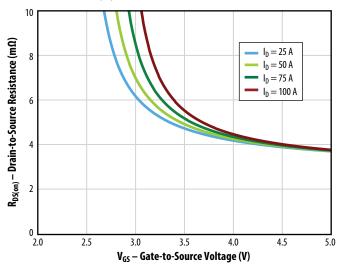


Figure 7: Normalized Threshold Voltage vs. Temperature

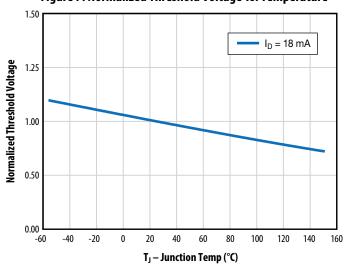


Figure 8: Normalized On-State Resistance vs. Temperature

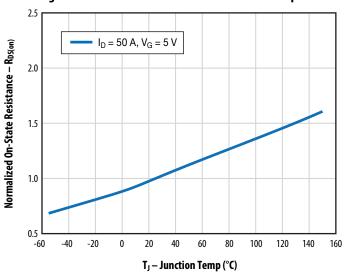


Figure 9: Typical Capacitance (Linear Scale)

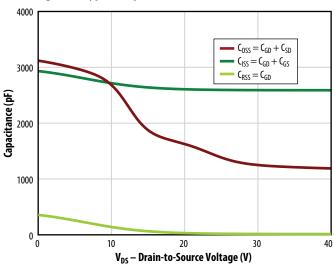


Figure 10: Typical Gate Charge

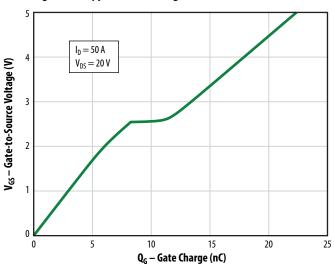
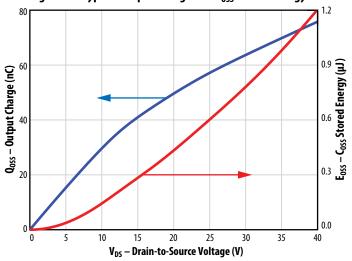


Figure 11: Typical Output Charge and Coss Stored Energy





Package Outline and Dimensions

Package outline to be added in final datasheet. Approximate dimensions = 8 mm (L) x 5.6 mm (W) x 1.6 mm (H)

EPC7019G Datasheet

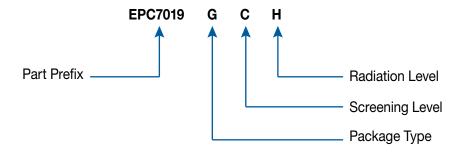


Notes

- Note 1. NEVER exceed the absolute maximum V_{DS} of the device otherwise permanent damage/destruction may result.
- Note 2. NEVER exceed the absolute maximum V_{GS} of the device otherwise permanent damage/destruction may result. We recommend use at no greater than +5 V as the HEMT is fully conducting at this point.
- Note 3. $R_{\theta,JA}$ measured with LCC3 package mounted to double-sided PCB, 0.063" thickness with 1.0 square inches of copper area on the top (mounting side) and a flood etch (3 square inches) on the bottom side.
- Note 4. Measured using four wire (Kelvin) sensing and pulse measurement techniques. Measurement pulse width is 80 µs and duty cycle is 1%, maximum.
- Note 5. Operation of the device in the third quadrant region is not recommended.
- Note 6. Guaranteed by design/device construction. Not tested.



EPC Space Part Number Information



Ordering Information Availability

Screening Options	Rad Assurance Options
1 character	1 character
C = Developmental Unit S = Space Level ¹	H = 1000 krad LET = 84

Part Number	Screening Level	Shipping
EPC7019GC	Developmental Units	Moffle Avers
EPC7019GSH	Space Level	Waffle trays

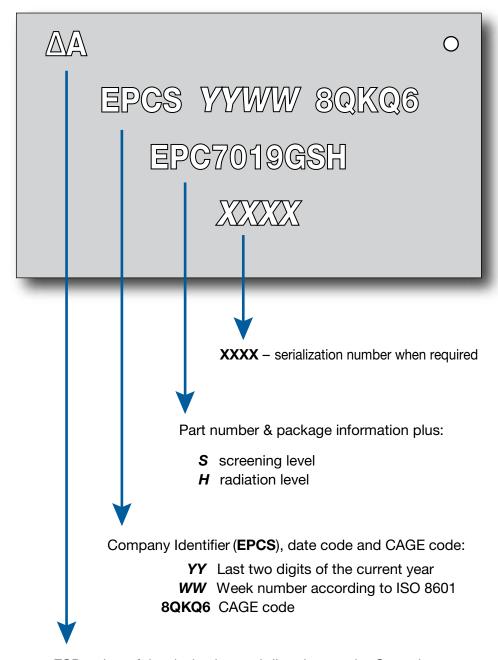
¹ Screening and qualification consistent to an equivalent MIL-PRF-19500 specification.

C version units are intended for engineering development purposes only and NOT supplied with radiation performance guarantees nor supplemental data packages.

EPC Space Rad Hard HEMT are not sensitive to Total Ionizing Dose as such the H level covers the R,F,G radiation levels.



EPC Space Product Marking Information



ESD rating of the device located directly over the Gate pin



Screening Flow Equivalent to a MIL-PRF-19500 General Specification

Operation Test Test Methods Per Mil STD 750 Sample Size Space Level COT Pre-Assembly Probe Testing EPC SPACE Internal 100% ✓ ✓ Post-Assembly Die Shear 2,017 5 ✓ ✓ X-Ray 2076 5 ✓ ✓ Serillalization 100% ✓ ✓ Electricals 3411,3413,3421,3404 100% ✓ ✓ Temp Cycling 1051 100% ✓ ✓ Constant Acceleration 2006 100% ✓ ✓ PIND 2052 100% ✓ ✓ Initial Electricals (Read and Record) 3411,3413,3421,3404 100% ✓ ✓ HTGB 1042 Condition A 240 Hours 100% ✓ ✓ Screening Final Electricals (Read and Record) 3411,3413,3421,3404 100% ✓ ✓ Screening Final Electricals (High and Low Temperatures) 3411,3413,3421,3404 100% ✓ ✓ Screen		EPC SPACE Qual Flow Equivalen	EPC SPACE Qual Flow Equivalent to a MIL-PRF-19500 Specification				
Visual inspection EPC SPACE Internal 100%	Operation	Test	Test Methods Per Mil STD 750	Sample Size	Space Level	СОТ	
Post-Assembly Die Shear 2,017 5	Due Assembly	Probe Testing	EPC SPACE Internal	100%	✓	✓	
Name	Pre-Assembly Visual inspection		EPC SPACE Internal	100%	✓	✓	
Serilalization 100%	Die Shear		2,017	5	✓	✓	
Electricals 3411,3413,3421,3404 100%	Post-Assembly	X-Ray	2076	5	✓	✓	
Temp Cycling		Serilialization		100%	✓		
Constant Acceleration 2006 100% V		Electricals	3411,3413,3421,3404	100%	✓	✓	
PIND 2052 100% V		Temp Cycling	1051	100%	✓		
Initial Electricals (Read and Record) 3411,3413,3421,3404 100% ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓ ✓		Constant Acceleration	2006	100%	✓		
HTGB		PIND	2052	100%	✓		
Interim Electricals (Read and Record) 3411,3413,3421,3404 100% ✓		Initial Electricals (Read and Record)	3411,3413,3421,3404	100%	✓		
HTRB		HTGB	1042 Condition B	100%	✓		
Screening Final Electricals (Read and Record) 3411,3413,3421,3404 100% ✓ Final Electricals (High and Low Temperatures) 3411,3413,3421,3404 100% ✓ Deltas Per Procurement Specification 100% ✓ Percent Defective Allowable Per Procurement Specification 100% ✓ Dynamic RDSON EPC SPACE Internal 100% ✓ V-RAY 2076 100% ✓ Tinning 100% ✓ Hermetic Seal, Fine & Gross Leak 1071 100% ✓ Final Electricals 3411,3413,3421,3404 100% ✓ Group A Inspection (Conformance) A-3 High & Low Temp DC Static Tests 3411,3413,3421,3404 116 ✓		Interim Electricals (Read and Record)	3411,3413,3421,3404	100%	✓		
Final Electricals (High and Low Temperatures) 3411,3413,3421,3404 100% ✓ Deltas Per Procurement Specification 100% ✓ Percent Defective Allowable Per Procurement Specification 100% ✓ Dynamic RDSON EPC SPACE Internal 100% ✓ OutLiers Removal EPC SPACE Internal 100% ✓ X-RAY 2076 100% ✓ Tinning 100% ✓ Hermetic Seal, Fine & Gross Leak 1071 100% ✓ Final Electricals 3411,3413,3421,3404 100% ✓ A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance)		HTRB	1042 Condition A 240 Hours	100%	✓		
Deltas Per Procurement Specification 100% ✓ Percent Defective Allowable Per Procurement Specification 100% ✓ Dynamic RDSON EPC SPACE Internal 100% ✓ OutLiers Removal EPC SPACE Internal 100% ✓ X-RAY 2076 100% ✓ Tinning 100% ✓ Hermetic Seal, Fine & Gross Leak 1071 100% ✓ Final Electricals 3411,3413,3421,3404 100% ✓ A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance) A-3 High & Low Temp DC Static Tests 3411,3413,3421,3404 116 ✓	Screening	Final Electricals (Read and Record)	3411,3413,3421,3404	100%	✓		
Percent Defective Allowable Per Procurement Specification 100% ✓ Dynamic RDSON EPC SPACE Internal 100% ✓ OutLiers Removal EPC SPACE Internal 100% ✓ X-RAY 2076 100% ✓ Tinning 100% ✓ Hermetic Seal, Fine & Gross Leak 1071 100% ✓ Final Electricals 3411,3413,3421,3404 100% ✓ A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance) A-3 High & Low Temp DC Static Tests 3411,3413,3421,3404 116 ✓		Final Electricals (High and Low Temperatures)	3411,3413,3421,3404	100%	✓		
Dynamic RDSON EPC SPACE Internal 100% ✓ OutLiers Removal EPC SPACE Internal 100% ✓ X-RAY 2076 100% ✓ Tinning 100% ✓ Hermetic Seal, Fine & Gross Leak 1071 100% ✓ Final Electricals 3411,3413,3421,3404 100% ✓ A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance) A-3 High & Low Temp DC Static Tests 3411,3413,3421,3404 116 ✓		Deltas	Per Procurement Specification	100%	✓		
OutLiers Removal EPC SPACE Internal 100% ✓ X-RAY 2076 100% ✓ Tinning 100% ✓ Hermetic Seal, Fine & Gross Leak 1071 100% ✓ Final Electricals 3411,3413,3421,3404 100% ✓ A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance) A-3 High & Low Temp DC Static Tests 3411,3413,3421,3404 116 ✓		Percent Defective Allowable	Per Procurement Specification	100%	✓		
X-RAY 2076 100% ✓ Tinning 100% ✓ Hermetic Seal, Fine & Gross Leak 1071 100% ✓ Final Electricals 3411,3413,3421,3404 100% ✓ A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance) A-3 High & Low Temp DC Static Tests 3411,3413,3421,3404 116 ✓		Dynamic RDSON	EPC SPACE Internal	100%	✓		
Tinning 100% ✓ Hermetic Seal, Fine & Gross Leak 1071 100% ✓ Final Electricals 3411,3413,3421,3404 100% ✓ A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance)		OutLiers Removal	EPC SPACE Internal	100%	✓		
Hermetic Seal, Fine & Gross Leak 1071 100% ✓ Final Electricals 3411,3413,3421,3404 100% ✓ A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance) (Conformance)		X-RAY	2076	100%	✓		
Final Electricals 3411,3413,3421,3404 100% ✓ A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance)		Tinning		100%	✓		
A-2 DC Static Tests at 25°C 3411,3413,3421,3404 116 ✓ Group A Inspection (Conformance) A-3 High & Low Temp DC Static Tests 3411,3413,3421,3404 116 ✓		Hermetic Seal, Fine & Gross Leak	1071	100%	✓		
Group A Inspection (Conformance) A-3 High & Low Temp DC Static Tests 3411,3413,3421,3404 116 ✓		Final Electricals	3411,3413,3421,3404	100%	✓		
(Conformance)		A-2 DC Static Tests at 25°C	3411,3413,3421,3404	116	✓		
(Conformance) A-7 Gate Charges 3471 Condition R 45		A-3 High & Low Temp DC Static Tests	3411,3413,3421,3404	116	✓		
777 date charges	(Conformance)	A-7 Gate Charges	3471 Condition B	45	✓		
A-7 Capacitance 3473 45 ✓		A-7 Capacitance	3473	45	✓		
Group B Inspection (Conformance) B-1, B-2, B-3, B-4, B-5 Sample base equivalent to a MIL-PRF-19500 flow or as required by procurement specificcation		B-1 B-2 B-3 B-4 B-5				d by	
Group C Inspection (Conformance) C-1, C-2, C-3, C-4, C-6, C-7 Sample base performed yearly per package style equivalent to a MIL-PRF-19500 flow or as required by procurement specification							
Group D Inspection TID 1019 15 ✓	Group D Inspection	TID	1019	15	✓		
(Conformance) SEE 1080 5 ✓		SEE	1080	5	✓		
Group E Inspection (Qualification E-1, E-2, E-5, E-6 E-7 Performed during product introduction or a major process change equivalent to a MIL-PRF-19500 flow or as required by		E-1, E-2, E-5, E-6 E-7				nge	
Inspection) E8 Switching procurement specification	•	E8 Switching					



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Revisions

Datasheet Revision	Product Status
REV Q1	Characterization and Qualification
Preliminary	Production Released

Information subject to change without notice.

Revised March 2022